Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/828,888	GUAN ET AL.	
Examiner	**Art Unit**	
A. Dexter Tugbang	3729	

SEARCHED			
Class	Subclass	Date	Examiner
29	603.07 603.08 603.11 603.14 603.2	4/2/2007	ADT
	604		
360	119		
	120 122		
	125 126		
	313		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text Search: NPL (IEEE Xplore Database)	4/2/2007	ADT